

Search Notes

Application/Control No.

10/576,645

Examiner

Trinh T. Nguyen

Applicant(s)/Patent under
Reexamination

STOLTE ET AL.

Art Unit

3644

SEARCHED

Class	Subclass	Date	Examiner
119	14.01 14.02 14.08 14.14 14.18	1/2/2010	TTN
	14.13		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor name search.	1/2/2010	TTN
A01J 5/017,5/00,7/00		